

#### **Features**

- · 3rd generation SiC MOSFET technology
- · Optimized package with separate driver source pin
- · High blocking voltage with low on-resistance
- · High-speed switching with low capacitances
- · Fast intrinsic diode with low reverse recovery (Q<sub>rr</sub>)
- · Halogen free, RoHS compliant

#### **Benefits**

- · Reduce switching losses and minimize gate ringing
- · Higher system effciency
- · Reduce cooling requirements
- · Increase power density
- · Increase system switching frequency

### **Applications**

- · Renewable energy
- · EV battery chargers
- · High voltage DC/DC converters
- · Switch Mode Power Supplies

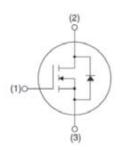
Ordering Part Number	Package	Qty(PCS)
SCT2160KEC	TO-247	30







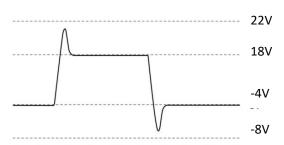
TO-247 Package



## Maximum Ratings (Tc = 25°C unless otherwise specifed)

Parameter	Symbol	Value	Unit
Drain-source voltage	Vos	1200	V
Continuous drain current  Tc = 25°C  Tc = 100°C	lo	17 12	А
Pulsed drain current (Tc = 25°C, tp limited by T <sub>jmax</sub> )	D pulse	34	Α
Avalanche energy, single pulse (L=10mH)	Eas	1000	mJ
Gate-Source voltage	Vgs	-4/+18	V
Gate-Source voltage(dynamic,Absolute maximum values)	VGSmax	-8/+22	V
Power dissipation (Tc = 25°C)	Ptot	116	W
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55+175	°C

• Example of acceptable Vgs waveform





## **Thermal Resistance**

Parameter	Symbol	Value	Unit
Thermal resistance, junction – case. Max	RthJC	1.29	°C/W
Thermal resistance, junction – ambient. Max	RthJA	40	C/VV

# Electrical Characteristics (at T<sub>j</sub> = 25 °C, unless otherwise specified)

Daramatar	Cumbal		Value		l lmi4	Unit Toot Condition
Parameter	Symbol	min.	typ.	max.	Unit	Test Condition
Static Characteristics						
Drain-source breakdown voltage	BVoss	1200	-	-	V	Vgs=0V, ID=100uA
Gate threshold voltage	VGS(th)	2	3.1	4	V	Vps=Vgs,Ip=2.3mA
Zero gate voltage drain current	Ibss	-	1 5	20 -	μA	V <sub>DS</sub> =1200V,V <sub>GS</sub> =0V T <sub>j</sub> =25°C T <sub>j</sub> =175°C
Gate-source leakage current	Igss	-		200	nA	Vgs=18V,Vps=0V
Drain-source on-state resistance	RDS(on)	-	160 250	208	m	Vgs=18V,lb=8A, Tj=25°C Tj=175°C
Transconductance	<b>g</b> fs	-	5	-	S	Vps=20V,lp=40A
Dynamic Characteristics						
Input Capacitance	Ciss	-	624	-		Vps = 1000V
Output Capacitance	Coss	-	42	-	pF	$V_{GS} = 0V$ $T_{J} = 25^{\circ}C$
Reverse Transfer Capacitance	Crss	-	6	-		V <sub>AC</sub> = 25mV f = 1MHz
Gate Total Charge	QG	-	37.4	-		Vps = 800V
Gate-Source charge	Qgs	-	5.3	-	nC	Vgs = -0/18V
Gate-Drain charge	Qgd	-	20.6	-		I <sub>D</sub> =8A I <sub>G</sub> =10mA
Turn-On Switching Energy	Eon	-	11	-	1	
Turn-Off Switching Energy-	Eoff	-	230		μJ	VDD = 800V
Turn-on delay time	td(on)	-	12.25	-		Vgs = -4/+18V ID =8A
Rise time	tr	-	18.68	-	na	Rg = 5
Turn-off delay time	td(off)	-	17.37	-	ns	L = 120uH
Fall time	tf	-	11.82	-		
Gate resistance	Rg	-	3.3	-		Vac = 25mV, f=1MHz



# **Body Diode Characteristics**

Parameter	Symbol	mbol Value Unit Test Condition	Value			
	Syllibol	min.	typ.	max.	Oilit	rest condition
Body Diode Forward Voltage	Vsp		3.6		V	Vgs=0V,Isb=40A, TJ=25°C
Body Diode Polward Voltage	VSD		3.2		V	Vgs=0V,Isp=40A, T <sub>J</sub> =175°C
Body Diode Reverse Recovery Time	trr	-	13.5	-	ns	V <sub>R</sub> = 400V, I <sub>D</sub> = 8A
Body Diode Reverse Recovery Charge	Qrr	-	36.8	-	nC	di/dt = 1000A/μS T <sub>J</sub> =25°C



### **Typical Performance Characteristics**

Fig 1. Output Characteristic (T<sub>J</sub>=-55°C)

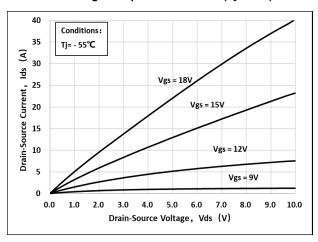


Fig 2. Output Characteristic (T<sub>J</sub>=25℃)

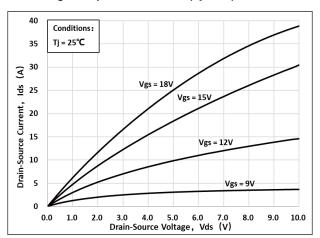


Fig 3. Output Characteristic (T<sub>J</sub>=175℃)

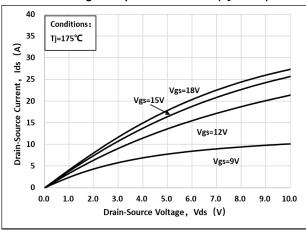


Fig 4: Rdson Vs Ids Characteristic

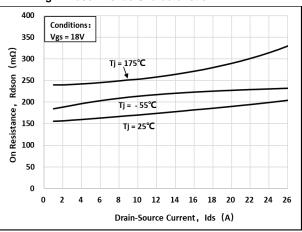


Fig 5: Rds(on) vs. Temperature

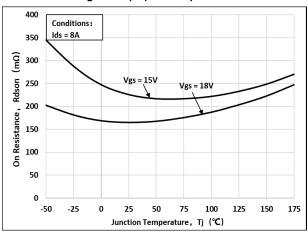


Fig 6: Transfer Characteristic

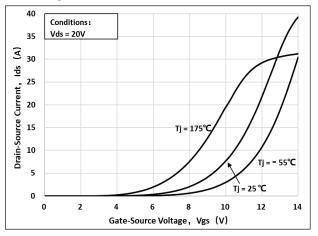




Fig 7: Body-diode Characteristic (T<sub>J</sub>=-55°C)

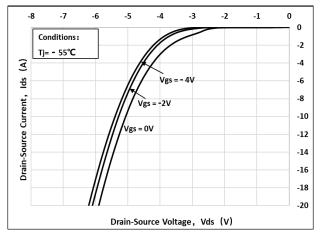


Fig 8: Body-diode Characteristic (T<sub>J</sub>=25℃)

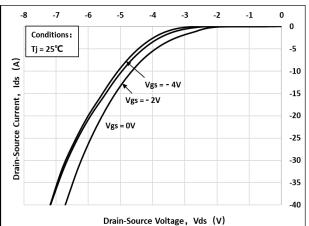


Fig 9: Body-diode Characteristic (T<sub>J</sub>=175℃)

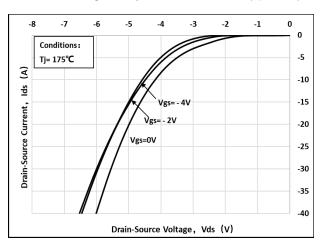


Fig 10: V<sub>TH</sub> Vs T<sub>J</sub> Temperature Characteristic

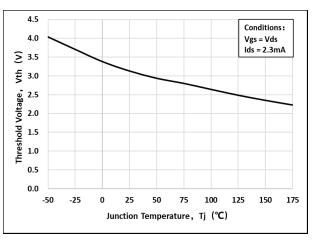


Fig 11: Gate Charge Characteristics

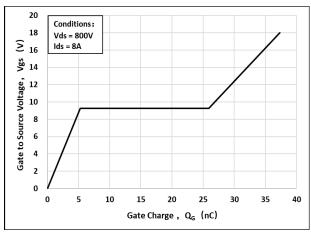


Fig 12: 3rd Quadrant Characteristic(T<sub>J</sub>=-55°C)

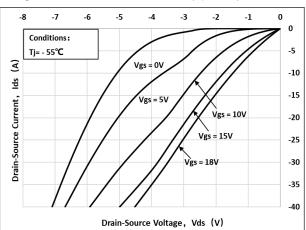




Fig 13: 3rd Quadrant Characteristic(T<sub>J</sub>=25℃)

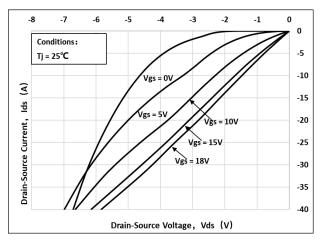


Fig 14: 3rd Quadrant Characteristic(T<sub>J</sub>=175℃)

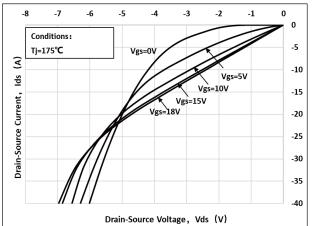


Fig 15: Capacitance Characteristic

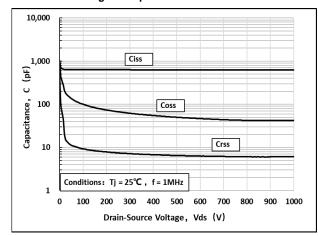


Fig 16: Safe Operating Area

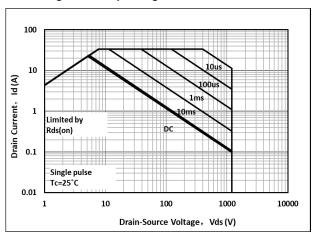
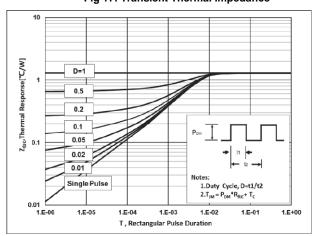


Fig 17: Transient Thermal Impedance





### **Test Circuit Schematic**

Figure A. Definition of switching times

#### Figure B. Dynamic test circuit

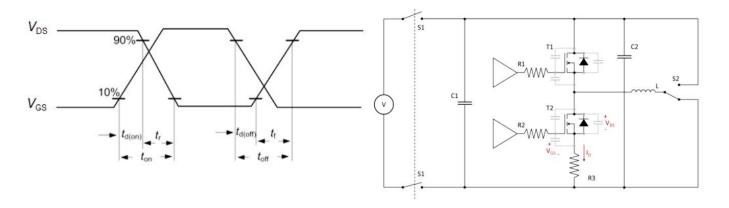


Figure C. Definition of body diodeswitching characteristics

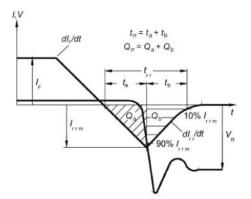
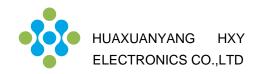
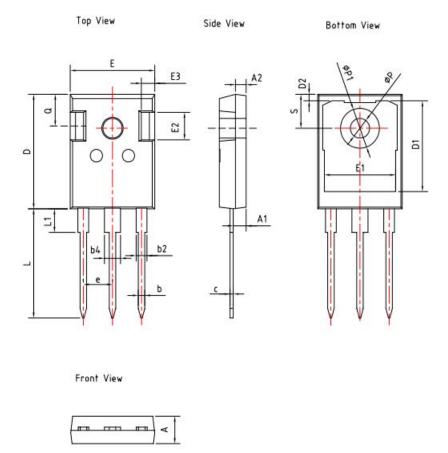


Figure C. **Definition of diode switching** characteristics



# **Package Dimensions**

Package TO-247



		Dimension unit:[mm	n)		
SYMBOL	MIN	NOM	MAX		
Α	4.80	5.00	5.20		
A1	2.21	2.41	2.61		
A2	1.85	2.00	2.15		
b	1.11	1.21	1.36		
b2	1.91	2.01	2.21		
b4	2.91	3.01	3.21		
c	0.51	0.60	0.75		
D	20.70	21.00	21.30		
D1	16.25	16.55	16.85		
D2	1.00	1.20	1.35		
E	15.50	15.80	16.10		
E1	13.00	13.30	13.60		
E2	4.80	5.00	5.20		
E3	2.30	2.50	2.70		
e	5.44 BSC				
L	19.62	19.92	20.22		
L1	100	+	4.30		
φP	3.40	3.60	3.80		
ØP1		-	7.30		
Q	5.40	5.80	6.20		
s	6.20 BSC				

#### SiC Power MOSFET N-Channel Enhancement Mode

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